



# Certificate of Analysis

## IARM 52D

Alloy K500 / UNS N05500

### Certified Reference Material

Certified Values listed in wt.% with associated uncertainties

<b>Al</b>	<b>2.95 ± 0.03</b>	<b>B</b>	<b>0.0020 ± 0.0008</b>	<b>C</b>	<b>0.125 ± 0.003</b>	<b>Co</b>	<b>0.005 ± 0.003</b>
<b>Cr</b>	<b>0.004 ± 0.002</b>	<b>Cu</b>	<b>29.6 ± 0.1</b>	<b>Fe</b>	<b>1.38 ± 0.03</b>	<b>Mg</b>	<b>0.0065 ± 0.0009</b>
<b>Mn</b>	<b>0.59 ± 0.01</b>	<b>Nb</b>	<b>0.002 ± 0.001</b>	<b>Ni</b>	<b>64.5 ± 0.2</b>	<b>P</b>	<b>0.002 ± 0.001</b>
<b>Pb</b>	<b>0.0020 ± 0.0009</b>	<b>S</b>	<b>0.0012 ± 0.0009</b>	<b>Si</b>	<b>0.170 ± 0.005</b>	<b>Sn</b>	<b>0.0013 ± 0.0005</b>
<b>Ti</b>	<b>0.60 ± 0.01</b>	<b>V</b>	<b>0.0010 ± 0.0009</b>	<b>Zr</b>	<b>0.026 ± 0.005</b>		

Indicative Values listed in ppm

Ag (6)	As (<30)	Au (<1)	Ba (<1)	Be (<1)	Bi (<30)	Br (<1)
Ca (<30)	Cd (<1)	Ce (<1)	Cl (<1)	Cs (<1)	Dy (<1)	Er (<1)
Eu (<1)	F (<1)	Ga (3.2)	Gd (<1)	Ge (2)	Hf (0.8)	Hg (<1)
Ho (<1)	I (<1)	In (<1)	Ir (<1)	K (<5)	La (<1)	Li (<1)
Lu (<1)	Mo (20)	N (<20)	Na (<5)	Nd (<1)	O (4)	Os (<1)
Pd (<20)	Pr (<1)	Pt (<1)	Rb (<10)	Re (<1)	Rh (<4)	Ru (<1)
Sb (<40)	Sc (<1)	Se (<7)	Sm (<1)	Sr (<20)	Ta (<100)	Tb (<1)
Te (<1)	Th (<1)	Tl (<1)	Tm (<1)	U (<1)	W (<80)	Y (<5)
Yb (<1)	Zn (11)					

#### Description and Intended Use

This CRM may come in the form of a solid disc or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

#### Interpretation of Data

1. Certified values listed reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community, and are reported as wt% unless otherwise noted.
2. This material was tested using both the solid disks and chips prepared from individual sections of bar. The certified values are considered representative of the overall average composition of the material.
3. Any data reported and enclosed by a parentheses ( ) is a "best estimate" and is not certified. This data could not be quantified sufficiently for certification. It was, however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
4. "Provisional Certificate of Analysis" reports values that support a fully certified reference material; it also indicates that values may be in a continued process of statistical evaluation and are subject to change.
5. Chips are not certified for Oxygen analysis.



The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material.

	Al	B	C	Co	Cr	Cu	Fe	Mg	Mn	Nb	Ni	P	Pb	S	Si	Sn
1	2.887	0.0013	0.1171	0.00036	0.00064	29.13	1.291	0.0049	0.5491	0.000015	64.06	0.00015	0.001	0.0002	0.1558	0.00071
2	2.898	0.0016	0.12	0.0004	0.00081	29.25	1.32	0.0054	0.579	0.00002	64.10	0.0002	0.0013	0.0002	0.159	0.00073
3	2.91	0.0019	0.12	0.00064	0.00083	29.34	1.35	0.0055	0.5802	0.001	64.3482	0.001	0.0013	0.0002	0.1593	0.00083
4	2.911	0.0019	0.12415	0.001	0.0013	29.425	1.36	0.006	0.5829	0.002	64.36	0.0012	0.0016	0.0004	0.16	0.001
5	2.947	0.002	0.125	0.001	0.002	29.4255	1.364	0.0063	0.586	0.003	64.637	0.002	0.0018	0.0005	0.164	0.0013
6	2.95	0.0034	0.125	0.0014	0.0022	29.47	1.365	0.0069	0.59	0.003	64.65	0.003	0.002	0.00086	0.1665	0.002
7	2.96		0.1259	0.0075	0.0051	29.6054	1.371	0.0072	0.59	0.0039	64.6998	0.0043	0.0025	0.001	0.17	0.002
8	2.97		0.128	0.0077	0.0055	29.6405	1.3789	0.0076	0.59		64.83		0.0042	0.0011	0.17	0.0022
9	2.978		0.128	0.0095	0.0056	29.654	1.383	0.0083	0.5921					0.0024	0.171	
10	2.9891		0.1286	0.01	0.01	29.70	1.403		0.595					0.0028	0.1733	
11	2.99		0.132	0.01	0.01	29.75	1.422		0.595					0.004	0.177	
12	3.036					29.79	1.45		0.60						0.18	
13						30.00	1.4608		0.63						0.18	
14															0.18	
15															0.1846	
Mean	2.95	0.002	0.125	0.005	0.004	29.6	1.38	0.0065	0.59	0.002	64.5	0.002	0.002	0.0012	0.17	0.0013
STDV.	0.04	0.0007	0.004	0.004	0.004	0.2	0.05	0.001	0.02	0.002	0.3	0.002	0.001	0.001	0.009	0.0006
<b>Certified</b>	<b>2.95</b>	<b>0.0020</b>	<b>0.125</b>	<b>0.005</b>	<b>0.004</b>	<b>29.6</b>	<b>1.38</b>	<b>0.0065</b>	<b>0.59</b>	<b>0.002</b>	<b>64.5</b>	<b>0.002</b>	<b>0.0020</b>	<b>0.0012</b>	<b>0.170</b>	<b>0.0013</b>
95% C.I.	0.03	0.0008	0.003	0.003	0.002	0.1	0.03	0.0009	0.01	0.001	0.2	0.001	0.0009	0.0009	0.005	0.0005
Methods	X,O,I,G	O,IM,G	O,C	X,O,IM,I,G	X,O,IM,G	X,W,O,I,G	X,O,I,G	O,IM,I,G	X,O,IM,I,G	O,IM,G	X,O,I,G	X,O,IM,G	O,IM,I,G	X,O,G,C	X,O,IM,I,G	X,O,IM,G

	Ti	V	Zr	Ag	As	Au	Ba	Be	Bi	Br	Ca	Cd	Ce	Cl	Cs	Dy
1	0.557	0.0002	0.016	0.00058	0.0001	<0.00001	<0.000005	0.0000005	0.000009	<0.000005	0.00011	<0.00002	0.000027	0.000011	<0.000001	<0.000001
2	0.58	0.00027	0.021	0.00062	0.00012	<0.00005	<0.00003	<0.000005	0.00001	<0.00005	0.00016	<0.00005	<0.000005	<0.000001	<0.00001	<0.000005
3	0.59	0.0003	0.021	0.00069	0.00025	<0.00005	<0.00005	<0.00001	0.00021		0.00025	<0.00005	<0.00005		<0.00005	<0.00005
4	0.59	0.0006	0.025		<0.001				<0.000005		<0.0005					
5	0.6055	0.0012	0.0295													
6	0.606	0.0016	0.03													
7	0.608	0.003	0.0311													
8	0.6096		0.0311													
9	0.61															
10	0.611															
11	0.62															
12	0.621															
13	0.6212															
14	0.6325															
15																
Mean	0.6	0.001	0.026	0.0006	0.001				0.001		0.001					
STDV.	0.02	0.001	0.006	0.00006	0.001				0.001		0.001					
<b>Certified</b>	<b>0.60</b>	<b>0.0010</b>	<b>0.026</b>	<b>(0.0006)</b>	<b>(&lt;0.003)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.003)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.003)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>
95% C.I.	0.01	0.0009	0.005													
Methods	X,O,IM,I,G	X,O,IM,G	X,O,IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G

	Er	Eu	F	Ga	Gd	Ge	Hf	Hg	Ho	I	In	Ir	K	La	Li	Lu
1	<0.000001	<0.000001	<0.00001	0.00032	<0.000001	0.00014	0.000069	<0.00001	<0.000005	<0.000001	<0.00001	0.000016	0.000018	0.000002	0.000001	<0.000001
2	<0.000005	<0.000005	<0.00001	0.00032	<0.000005	0.00017	0.00008	<0.00005	<0.00001	<0.00001	<0.00001	<0.00001	<0.000005	<0.000005	<0.000005	<0.000005
3	<0.00005	<0.00005		0.00032	<0.00005	<0.0002	0.000084	<0.00005	<0.00005		<0.00005	<0.00005	<0.0005	<0.00001	<0.00001	<0.000005
4																
5																
6																
7																
8																
9																
10																
Mean						0.0002	0.00008									
STDV.						0.00002	0.000008									
<b>Certified</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(0.00032)</b>	<b>(&lt;0.0001)</b>	<b>(0.0002)</b>	<b>(0.00008)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0005)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>
95% C.I.																
Methods	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G

	Mo	N	Na	Nd	O	Os	Pd	Pr	Pt	Rb	Re	Rh	Ru	Sb	Sc	Se
1	0.00038	0.0001	0.00001	<0.000001	0.00012	0.000013	0.000034	<0.000001	<0.00001	<0.00005	0.000015	<0.00001	<0.00001	0.00013	<0.000005	0.00048
2	0.001	0.001	<0.000001	<0.000005	0.0002	0.000024	<0.00005	<0.000005	<0.00001	<0.0001	0.000021	<0.00005	<0.0001	0.00015	<0.00001	<0.00005
3	0.001	0.0015	<0.0005	<0.00005	0.0004	<0.00005	<0.0015	<0.00005	<0.00005	<0.001	<0.00005	<0.0004	<0.0001	0.00016	<0.00005	<0.0007
4	0.003				0.001									0.0037		
5	0.0033															
6	0.006															
7																
8																
9																
10																
Mean	0.002	0.001			0.0004	0.00002					0.000018			0.001		
STDV.	0.002	0.0007			0.0003	0.000008					0.000003			0.002		
<b>Certified</b>	<b>(0.002)</b>	<b>(&lt;0.002)</b>	<b>(&lt;0.0005)</b>	<b>(&lt;0.0001)</b>	<b>(0.0004)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.002)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0004)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.004)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0007)</b>
95% C.I.																
Methods	X,O,IM,G	F	IM,G	IM,G	F	IM,G	IM,G	IM,G	IM,G	IM,G	X,IM,G	IM,G	IM,G	IM,G	IM,G	IM,G

	Sm	Sr	Ta	Tb	Te	Th	Tm	Tl	U	W	Y	Yb	Zn
1	<0.000001	<0.00005	0.0052	<0.000001	0.000028	<0.000001	<0.000001	<0.000001	0.0000016	0.000021	<0.00005	<0.000001	0.00084
2	<0.000005	<0.0005	0.007	<0.000005	<0.00001	<0.000001	<0.000005	<0.000005	0.000002	0.000031	<0.0001	<0.000005	0.00098
3	<0.00005	<0.002	0.01	<0.00005	<0.00005	<0.00005	<0.00005	<0.00005	<0.00005	0.001	<0.0005	<0.00005	0.0015
4			<0.000001							0.0018			
5			<0.00001							0.008			
6			<0.00005							<0.00005			
7													
8													
9													
10													
Mean			0.007						0.000002	0.002			0.0011
STDV.			0.002						0.0000003	0.003			0.0003
<b>Certified</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.002)</b>	<b>(&lt;0.01)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.0001)</b>	<b>(&lt;0.008)</b>	<b>(&lt;0.0005)</b>	<b>(&lt;0.0001)</b>	<b>(0.0011)</b>
95% C.I.													
Methods	IM,G	IM,G	X,O,IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	IM,G	X,O,IM,G	IM,G	IM,G	IM,G

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES



## Participating Laboratories

Anderson Laboratories, Inc. Colonial Metals Co. EAG Laboratories Laboratory Testing, Inc. MetalTek International, Inc. Oxford Instruments Analytical GmbH	Greendale, WI Columbia, PA Liverpool, NY Hatfield, PA Waukesha, WI Uedem, Germany	ATI Specialty Materials, Lockport Cronimet Specialty Metals USA, Inc Laboratorio Prove Materiali S. Marco srl Leco Corporation Northern Analytical Laboratory, Inc. VHG Labs	Lockport, NY Wheatland, PA Schio, Italy St. Joseph, MI Londonderry, NH Manchester, NH
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## Traceability

Members of the "Inter-Laboratory Analysis Program" (ILAP) validate test methods and instrument performance utilizing SRMs, CRMs, and RMs produced by recognized Certifying Bodies. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are:

ALPHA AR1648	ALPHA AR891	BAS 346A	IARM 241A	IARM 56D	IV K2-FE04057	LECO 501-502	NIST 1244	VHG 103665-13
ALPHA AR645	ALPHA AR914K	BAS 433/2	IARM 274A	IARM 63B	IV K2-MO02086	LECO 501-646	NIST 1245	VHG 118879R-33
ALPHA AR660	BRAMMER BS CSN2-2	IARM 100B	IARM 51A	IARM 68C	IV K2-NB01088	LECO 502-016	NIST 162A	VHG 119875R-20
ALPHA AR668	BRAMMER BS JK37	IARM 202A	IARM 52A	IV H2-CO2054R	IV K2-TI02119	LECO 502-348	NIST 864	VHG 710679419-1
ALPHA AR670	BRAMMER BS 500B	IARM 203A	IARM 52B	IV J2-MN02124	IV M2-NI654716	LECO 502-411	NIST 867	VHG 97415R-21
ALPHA AR890	BRAMMER BS 500D	IARM 206A	IARM 52C	IV J2-NB01082	LECO 0675-31	LECO 717	VHG 101593-12	

## Homogeneity and Uncertainty

"Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where  $N_{prod}$  is the number of units produced and  $N_{min}$  is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity is also determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculate uncertainty due to inhomogeneity ( $U_{hom}$ ). Uncertainty of the material is calculated by equation 2, where  $H=U_{hom}$ ,  $S$ = Standard deviation,  $t$ = t-value at 95% CI, and  $n$ = number of observations.

$$1. N_{min} = \max(10, \sqrt[3]{N_{prod}})$$

$$2. U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1992 list the following:

**Certifying Body:** Any technically competent body (organization or firm, public or private) that issues a reference material certificate with the information detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards or Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

**Reference Material (RM):** Material or substance, with one or more property values that are sufficiently homogeneous and well established, to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

**Certified Reference Material (CRM):** Reference material, accompanied by a certificate, with one or more property values certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

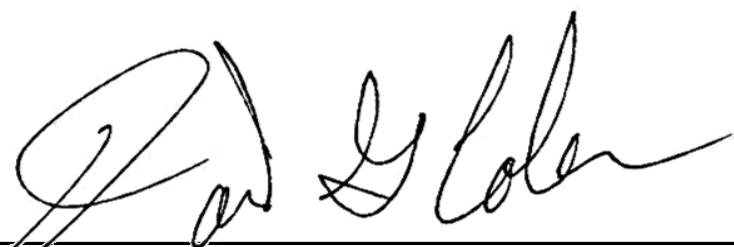
**Inter-Laboratory Analysis Program (ILAP):** ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", but also outlines a well thought out and logical plan for conducting an inter laboratory program involving multiple analytical techniques. Therefore, the guidelines established in ASTM E691-87 were applied to all aspects of this inter laboratory program, including the protocols for planning, handling, analysis and treatment of resulting data.

**Methods of Analysis:** The "Inter Laboratory Analysis Program" analyzes a wide variety of materials, and as a result, no single analytical method would provide optimum analytical results. Therefore, a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, X-Ray spectrometric, and other accepted methods were used to produce analytical data. Carbon, Sulfur, Nitrogen, and Oxygen results were supplied from combustion and OE instrument procedures.

**Expiration of Certification:** The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

**Instructions for Use:** The test surface is on the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. **Chips are not to be used for Oxygen analysis.**

**Selection of Materials:** A "batch" or "series" is defined as a continuous length of bar produced from a single heat. The majority of IARM materials are in wrought condition; other methods of manufacture are utilized if necessary. ILAP samples are removed from equal sections from the total length of the bar. A portion of each section is converted to chips and a thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis.



David Coler, General Manager

Analytical Reference Materials International



Analytical Reference Materials International • 276 Abby Road • Manchester, NH 03103  
 Telephone (603) 935-4100 • Fax (603) 935-4101 • www.ARMl.com • ARMI@LGCgroup.com

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